

<b>Notice of References Cited</b>	Application/Control No. 09/788,315	Applicant(s)/Patent Under Reexamination YOON ET AL.	
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#### U.S. PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
X	U	CAS printout of Teranishi et al. Chem. Abs. 114:101506, 1991
X	V	CAS printout of McCapra et al. Chem. Abs. 79:125387, 1973
X	W	CAS printout of Inoue et al. Chem. Abs. 93:114448, 1980
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*	N	WO 9838174 A1	09-1998	World Intellect	COX et al.	C07D241/20
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*	U	CAS printout for Miesel et al. Chem. Abs. 96: 35307, 1982
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